

IDS 5/19/05

Form PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. M122-2359	SERIAL NO. 10/629,011
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT: Doan et al.	
		FILING DATE July 28, 2003	GROUP 2812

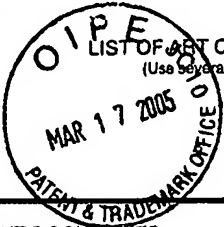
U.S. PATENT DOCUMENTS							
Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
94	AA	6,537,925	3/2003	Kim et al.			
94	AB	2001/0052323	12/2001	Yieh et al.			
94	AC	2002/0119673	8/2002	Yieh et al.			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
94	AJ	JP2002-305195	10/18/2002	Kyong-Min et al. (Japan)			Abstract	
94	AK	TW 478312 C2	3/11/2002	Yieh et al.			Abstract	
	AL							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)		
AM		
AN		
AO		
EXAMINER: <i>James M. Kennedy</i> DATE CONSIDERED: <i>July 7, 2005</i> *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		

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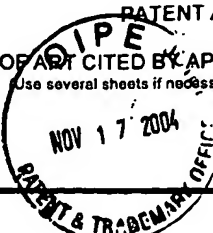
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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2359		SERIAL NO. 10/629,011		
 LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Doan et al.				
				FILING DATE July 28, 2003		GROUP 2812		
U.S. PATENT DOCUMENTS								
*Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
JK	AA	5,874,706	02/1999	Ishii et al.	219	121.43		
JK	AB	6,158,383	12/2000	Watanabe et al.	118	723		
JK	AC	2002/0000598 A1	01/2002	Kang et al.	257	301		
JK	AD	2004/0038525 A1	02/2004	Meng et al.	438	656		
	AE							
	AF							
	AG							
	AH							
	AI							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
JK	AJ	WO 02/43114 A2	05/2002	WIPO (Nguyen)				
JK	AK	EP 1167567 A1	01/2002	EPO (Xi et al.)				
JK	AL	JP 05343334 A	12/1993	JP (Kawai et al.)				
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
	AM							
	AN							
	AO							
EXAMINER		DATE CONSIDERED						
JK		M. Kennedy July 7, 2005						
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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2359	SERIAL NO. 10/629,011		
LIST OF ART CITED BY APPLICANT <small>(Use several sheets if necessary)</small>				APPLICANT: Trung Tri Doan et al.			
				FILING DATE July 28, 2003	GROUP 2643		
U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
<i>gu</i> <i>gu</i> <i>gu</i> <i>gu</i> <i>gu</i> <i>gu</i> <i>gu</i> <i>gu</i> <i>gu</i> <i>gu</i>	AA	5,976,623	11/2/1999	DeSantolo et al.			
	AB	6,015,762	1/18/2000	Yamazaki et al.			
	AC	6,416,822	7/9/2002	Chiang et al.			
	AD	6,468,924	10/22/2002	Lee et al.			
	AE	6,620,723	9/16/2003	Byun et al.			
	AF	6,630,201	10/7/2003	Chiang et al.			
	AG	2002/0076507 A1	6/20/2002	Chiang et al.			
	AH	2002/0197856 A1	12/26/2002	Matsuse et al.			
	AI	2003/0168001 A1	9/11/2003	Sneh			
	AJ	2004/0018304 A1	1/29/2004	Chung et al.			
AK							
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
<i>gu</i> <i>gu</i>	AL	WO02/045871 A1	6/13/2002	WIPO (Chiang et al.)			x
	AM	WO 03/087431 A2	10/23/2003	EIPO (Carpenter et al.)			x
	AN						
	AO						
AP							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
<i>gu</i>	AR	*The Film Processes*; Vossen et al.; 1978; Academic Press, Inc.; 5 pp.					
	AS						
EXAMINER		DATE CONSIDERED					
<i>Gmif M. Kennedy</i>		<i>July 7, 2005</i>					
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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-2359		SERIAL NO. 10/293,072 (priority)		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Trung Tri Doan, et al.				
				FILING DATE November 12, 2002 (priority)		GROUP 2812 (priority)		
U.S. PATENT DOCUMENTS								
*Examiner's Initials	Class	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
JH	AA	6,200,893 B1	3/13/01	Sneh	438	685	/	
JH	AB	6,343,565 B1	2/5/02	Hongoh	118	723		
JH	AC	6,355,561 B1	3/12/02	Sandhu, et al.	438	676		
JH	AD	6,369,763 B1	4/9/02	Norris, et al.	343	701		
JH	AE	6,399,520 B1	6/4/02	Kawakami, et al.	438	778		
JH	AF	10/293,025	—	Blalock, et al. (as filed)			11/2/02	
	AG							
	AH							
	AI							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AJ							
	AK							
	AL							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
JH	AM		Yamamoto, et al. - Design of Radial Line Slot Antennas at 8.3 GHz for Large Area Uniform Plasma Generation					
	AN		/					
	AO							
EXAMINER		DATE CONSIDERED						
JH		M. Kennedy July 7, 2005						
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